S	earch	n Notes	

Application/Control No.	Applicant(s)/Patent under Reexamination	r
10/797,579	LEE ET AL.	
Examiner	Art Unit	
Michelle A. Lazor	1734	

	SEARCHED		
Class	Subclass	Date	Examiner
118	52,320	5/5/2005	MAL
427	420	5/5/2005	MAL
396	604,611	5/5/2005	MAL

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

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